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AMD Xilinx - XC3S500E-4FT256I Datasheet



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Understanding <u>Embedded - FPGAs (Field</u> <u>Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Product Status	Active
Number of LABs/CLBs	1164
Number of Logic Elements/Cells	10476
Total RAM Bits	368640
Number of I/O	190
Number of Gates	500000
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	256-LBGA
Supplier Device Package	256-FTBGA (17x17)
Purchase URL	https://www.e-xfl.com/product-detail/xilinx/xc3s500e-4ft256i

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Configuration

Spartan-3E FPGAs are programmed by loading configuration data into robust, reprogrammable, static CMOS configuration latches (CCLs) that collectively control all functional elements and routing resources. The FPGA's configuration data is stored externally in a PROM or some other non-volatile medium, either on or off the board. After applying power, the configuration data is written to the FPGA using any of seven different modes:

- Master Serial from a Xilinx Platform Flash PROM
- Serial Peripheral Interface (SPI) from an industry-standard SPI serial Flash
- Byte Peripheral Interface (BPI) Up or Down from an industry-standard x8 or x8/x16 parallel NOR Flash
- Slave Serial, typically downloaded from a processor
- Slave Parallel, typically downloaded from a processor
- Boundary Scan (JTAG), typically downloaded from a processor or system tester.

Furthermore, Spartan-3E FPGAs support MultiBoot configuration, allowing two or more FPGA configuration bitstreams to be stored in a single parallel NOR Flash. The FPGA application controls which configuration to load next and when to load it.

I/O Capabilities

The Spartan-3E FPGA SelectIO interface supports many popular single-ended and differential standards. Table 2 shows the number of user I/Os as well as the number of differential I/O pairs available for each device/package combination.

Spartan-3E FPGAs support the following single-ended standards:

- 3.3V low-voltage TTL (LVTTL)
- Low-voltage CMOS (LVCMOS) at 3.3V, 2.5V, 1.8V, 1.5V, or 1.2V
- 3V PCI at 33 MHz, and in some devices, <u>66 MHz</u>
- HSTL I and III at 1.8V, commonly used in memory applications
- SSTL I at 1.8V and 2.5V, commonly used for memory applications

Spartan-3E FPGAs support the following differential standards:

- LVDS
- Bus LVDS
- mini-LVDS
- RSDS
- Differential HSTL (1.8V, Types I and III)
- Differential SSTL (2.5V and 1.8V, Type I)
- 2.5V LVPECL inputs

Package	VQ1 VQG	00 100	CP CPC	132 3132	TQ TQC	144 6144	PQ PQC	208 6208	FT: FTG	256 1256	FG FGC	320 3320	FG FGC	400 6400	FG4 FGG	484 i484
Footprint Size (mm)	16 x	16	8	x 8	22 >	c 22	30.5 >	c 30.5	17 :	k 17	19 3	c 19	21 :	x 21	23 >	x 23
Device	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff	User	Diff
XC3S100E	66⁽²⁾ 9(7)	30 (2)	83 (11)	35 (2)	108 (28)	40 (4)	-	-	-	-	-	-	-	-	-	-
XC3S250E	66 (7)	30 (2)	92 (7)	41 (2)	108 (28)	40 (4)	158 (32)	65 (5)	172 (40)	68 (8)	-	-	-	-	-	-
XC3S500E	66 ⁽³⁾ (7)	30 (2)	92 (7)	41 (2)	-	-	158 (32)	65 (5)	190 (41)	77 (8)	232 (56)	92 (12)	-	-	-	-
XC3S1200E	-	-	-	-	-	-	-	-	190 (40)	77 (8)	250 (56)	99 (12)	304 (72)	124 (20)	-	-
XC3S1600E	-	-	-	-	-	-	-	-	-	-	250 (56)	99 (12)	304 (72)	124 (20)	376 (82)	156 (21)

Table 2: Available User I/Os and Differential (Diff) I/O Pairs

Notes:

1. All Spartan-3E devices provided in the same package are pin-compatible as further described in Module 4, Pinout Descriptions.

2. The number shown in **bold** indicates the maximum number of I/O and input-only pins. The number shown in (*italics*) indicates the number of input-only pins.

3. The XC3S500E is available in the VQG100 Pb-free package and not the standard VQ100. The VQG100 and VQ100 pin-outs are identical and general references to the VQ100 will apply to the XC3S500E.

Package Marking

Figure 2 provides a top marking example for Spartan-3E FPGAs in the quad-flat packages. Figure 3 shows the top marking for Spartan-3E FPGAs in BGA packages except the 132-ball chip-scale package (CP132 and CPG132). The markings for the BGA packages are nearly identical to those for the quad-flat packages, except that the marking is rotated with respect to the ball A1 indicator. Figure 4 shows the top marking for Spartan-3E FPGAs in the CP132 and CPG132 packages. On the QFP and BGA packages, the optional numerical Stepping Code follows the Lot Code.

The "5C" and "4I" part combinations can have a dual mark of "5C/4I". Devices with a single mark are only guaranteed for the marked speed grade and temperature range. All "5C" and "4I" part combinations use the Stepping 1 production silicon.



Figure 2: Spartan-3E QFP Package Marking Example







Figure 4: Spartan-3E CP132 and CPG132 Package Marking Example



Notes:

- 1. Options to invert signal polarity as well as other options that enable lines for various functions are not shown.
- 2. The index i can be 6, 7, or 8, depending on the slice. The upper SLICEL has an F8MUX, and the upper SLICEM has an F7MUX. The lower SLICEL and SLICEM both have an F6MUX.

Figure 15: Simplified Diagram of the Left-Hand SLICEM

Table 10: Slice Inputs and Outputs (Cont'd)

Name	Location	Direction	Description
SHIFTOUT	SLICEM Bottom	Output	Shift data output from F-LUT RAM
CIN	SLICEL/M Bottom	Input	Carry chain input
COUT	SLICEL/M Top	Output	Carry chain output
х	SLICEL/M Bottom	Output	Combinatorial output
Y	SLICEL/M Top	Output	Combinatorial output
ХВ	SLICEL/M Bottom	Output	Combinatorial output from carry or F-LUT SRL16 (SLICEM)
YB	SLICEL/M Top	Output	Combinatorial output from carry or G-LUT SRL16 (SLICEM)
XQ	SLICEL/M Bottom	Output	FFX output
YQ	SLICEL/M Top	Output	FFY output

Main Logic Paths

Central to the operation of each slice are two nearly identical data paths at the top and bottom of the slice. The description that follows uses names associated with the bottom path. (The top path names appear in parentheses.) The basic path originates at an interconnect switch matrix outside the CLB. See Interconnect for more information on the switch matrix and the routing connections.

Four lines, F1 through F4 (or G1 through G4 on the upper path), enter the slice and connect directly to the LUT. Once inside the slice, the lower 4-bit path passes through a LUT 'F' (or 'G') that performs logic operations. The LUT Data output, 'D', offers five possible paths:

- 1. Exit the slice via line "X" (or "Y") and return to interconnect.
- Inside the slice, "X" (or "Y") serves as an input to the DXMUX (or DYMUX) which feeds the data input, "D", of the FFX (or FFY) storage element. The "Q" output of the storage element drives the line XQ (or YQ) which exits the slice.
- 3. Control the CYMUXF (or CYMUXG) multiplexer on the carry chain.
- 4. With the carry chain, serve as an input to the XORF (or XORG) exclusive-OR gate that performs arithmetic operations, producing a result on "X" (or "Y").
- 5. Drive the multiplexer F5MUX to implement logic functions wider than four bits. The "D" outputs of both the F-LUT and G-LUT serve as data inputs to this multiplexer.

In addition to the main logic paths described above, there are two bypass paths that enter the slice as BX and BY. Once inside the FPGA, BX in the bottom half of the slice (or BY in the top half) can take any of several possible branches:

1. Bypass both the LUT and the storage element, and then exit the slice as BXOUT (or BYOUT) and return to interconnect.

- Bypass the LUT, and then pass through a storage element via the D input before exiting as XQ (or YQ).
- 3. Control the wide function multiplexer F5MUX (or FiMUX).
- 4. Via multiplexers, serve as an input to the carry chain.
- 5. Drive the DI input of the LUT.
- 6. BY can control the REV inputs of both the FFY and FFX storage elements. See Storage Element Functions.
- 7. Finally, the DIG_MUX multiplexer can switch BY onto the DIG line, which exits the slice.

The control inputs CLK, CE, SR, BX and BY have programmable polarity. The LUT inputs do not need programmable polarity because their function can be inverted inside the LUT.

The sections that follow provide more detail on individual functions of the slice.

Look-Up Tables

The Look-Up Table or LUT is a RAM-based function generator and is the main resource for implementing logic functions. Furthermore, the LUTs in each SLICEM pair can be configured as Distributed RAM or a 16-bit shift register, as described later.

Each of the two LUTs (F and G) in a slice have four logic inputs (A1-A4) and a single output (D). Any four-variable Boolean logic operation can be implemented in one LUT. Functions with more inputs can be implemented by cascading LUTs or by using the wide function multiplexers that are described later.

The output of the LUT can connect to the wide multiplexer logic, the carry and arithmetic logic, or directly to a CLB output or to the CLB storage element. See Figure 18.

initialized distributed RAM contents are not disturbed during the configuration process.

The distributed RAM is useful for smaller amounts of memory. Larger memory requirements can use the dedicated 18Kbit RAM blocks (see Block RAM).

Shift Registers

For additional information, refer to the "Using Look-Up Tables as Shift Registers (SRL16)" chapter in UG331.

It is possible to program each SLICEM LUT as a 16-bit shift register (see Figure 28). Used in this way, each LUT can delay serial data anywhere from 1 to 16 clock cycles without using any of the dedicated flip-flops. The resulting programmable delays can be used to balance the timing of data pipelines.

The SLICEM LUTs cascade from the G-LUT to the F-LUT through the DIFMUX (see Figure 15). SHIFTIN and SHIFTOUT lines cascade a SLICEM to the SLICEM below to form larger shift registers. The four SLICEM LUTs of a single CLB can be combined to produce delays up to 64 clock cycles. It is also possible to combine shift registers across more than one CLB.



Figure 28: Logic Cell SRL16 Structure

Each shift register provides a shift output MC15 for the last bit in each LUT, in addition to providing addressable access to any bit in the shift register through the normal D output. The address inputs A[3:0] are the same as the distributed RAM address lines, which come from the LUT inputs F[4:1] or G[4:1]. At the end of the shift register, the CLB flip-flop can be used to provide one more shift delay for the addressable bit.

The shift register element is known as the SRL16 (Shift Register LUT 16-bit), with a 'C' added to signify a cascade ability (Q15 output) and 'E' to indicate a Clock Enable. See Figure 29 for an example of the SRLC16E component.



Figure 29: SRL16 Shift Register Component with Cascade and Clock Enable

The functionality of the shift register is shown in Table 20. The SRL16 shifts on the rising edge of the clock input when the Clock Enable control is High. This shift register cannot be initialized either during configuration or during operation except by shifting data into it. The clock enable and clock inputs are shared between the two LUTs in a SLICEM. The clock enable input is automatically kept active if unused.

	Inp	uts		Outputs			
Am	CLK	CE	D	Q	Q15		
Am	Х	0	Х	Q[Am]	Q[15]		
Am	\uparrow	1	D	Q[Am-1]	Q[15]		

Notes:

1. m = 0, 1, 2, 3.

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Block RAM

For additional information, refer to the "Using Block RAM" chapter in UG331.

Spartan-3E devices incorporate 4 to 36 dedicated block RAMs, which are organized as dual-port configurable 18 Kbit blocks. Functionally, the block RAM is identical to the Spartan-3 architecture block RAM. Block RAM synchronously stores large amounts of data while distributed RAM, previously described, is better suited for buffering small amounts of data anywhere along signal paths. This section describes basic block RAM functions.

Each block RAM is configurable by setting the content's initial values, default signal value of the output registers, port aspect ratios, and write modes. Block RAM can be used in single-port or dual-port modes.

Arrangement of RAM Blocks on Die

The block RAMs are located together with the multipliers on the die in one or two columns depending on the size of the device. The XC3S100E has one column of block RAM. The Spartan-3E devices ranging from the XC3S250E to XC3S1600E have two columns of block RAM. Table 21 shows the number of RAM blocks, the data storage capacity, and the number of columns for each device. Row(s) of CLBs are located above and below each block RAM column.

Device	Total Number of RAM Blocks	Total Addressable Locations (bits)	Number of Columns
XC3S100E	4	73,728	1
XC3S250E	12	221,184	2
XC3S500E	20	368,640	2
XC3S1200E	28	516,096	2
XC3S1600E	36	663,552	2

Table 21: Number of RAM Blocks by Device

Immediately adjacent to each block RAM is an embedded 18x18 hardware multiplier. The upper 16 bits of the block RAM's Port A Data input bus are shared with the upper 16 bits of the A multiplicand input bus of the multiplier. Similarly, the upper 16 bits of Port B's data input bus are shared with the B multiplicand input bus of the multiplier.

The Internal Structure of the Block RAM

The block RAM has a dual port structure. The two identical data ports called A and B permit independent access to the common block RAM, which has a maximum capacity of 18,432 bits, or 16,384 bits with no parity bits (see parity bits description in Table 22). Each port has its own dedicated set of data, control, and clock lines for synchronous read

and write operations. There are four basic data paths, as shown in Figure 30:

- 1. Write to and read from Port A
- 2. Write to and read from Port B
- 3. Data transfer from Port A to Port B
- 4. Data transfer from Port B to Port A



Figure 30: Block RAM Data Paths

Number of Ports

A choice among primitives determines whether the block RAM functions as dual- or single-port memory. A name of the form RAMB16_S[w_A]_S[w_B] calls out the dual-port primitive, where the integers w_A and w_B specify the total data path width at ports A and B, respectively. Thus, a RAMB16_S9_S18 is a dual-port RAM with a 9-bit Port A and an 18-bit Port B. A name of the form RAMB16_S[w] identifies the single-port primitive, where the integer w specifies the total data path width of the lone port A. A RAMB16_S18 is a single-port RAM with an 18-bit port.

Port Aspect Ratios

Each port of the block RAM can be configured independently to select a number of different possible widths for the data input (DI) and data output (DO) signals as shown in Table 22.

Configuration Bitstream Image Sizes

A specific Spartan-3E part type always requires a constant number of configuration bits, regardless of design complexity, as shown in Table 45. The configuration file size for a multiple-FPGA daisy-chain design roughly equals the sum of the individual file sizes.

Table 45: Number of Bits to Program a Spartan-3EFPGA (Uncompressed Bitstreams)

Spartan-3E FPGA	Number of Configuration Bits
XC3S100E	581,344
XC3S250E	1,353,728
XC3S500E	2,270,208
XC3S1200E	3,841,184
XC3S1600E	5,969,696

Pin Behavior During Configuration

For additional information, refer to the "Configuration Pins and Behavior during Configuration" chapter in <u>UG332</u>.

Table 46 shows how various pins behave during the FPGAconfiguration process. The actual behavior depends on the

Table 46: Pin Behavior during Configuration

values applied to the M2, M1, and M0 mode select pins and the HSWAP pin. The mode select pins determine which of the I/O pins are borrowed during configuration and how they function. In JTAG configuration mode, no user-I/O pins are borrowed for configuration.

All user-I/O pins, input-only pins, and dual-purpose pins that are not actively involved in the currently-select configuration mode are high impedance (floating, three-stated, Hi-Z) during the configuration process. These pins are indicated in Table 46 as gray shaded table entries or cells.

The HSWAP input controls whether all user-I/O pins, input-only pins, and dual-purpose pins have a pull-up resistor to the supply rail or not. When HSWAP is Low, each pin has an internal pull-up resistor that is active throughout configuration. After configuration, pull-up and pull-down resistors are available in the FPGA application as described in Pull-Up and Pull-Down Resistors.

The yellow-shaded table entries or cells represent pins where the pull-up resistor is always enabled during configuration, regardless of the HSWAP input. The post-configuration behavior of these pins is defined by Bitstream Generator options as defined in Table 69.

Pin Name	Master Serial	SPI (Serial Flash)	BPI (Parallel NOR Flash)	JTAG	Slave Parallel	Slave Serial	I/O Bank ⁽³⁾
IO* (user-I/O) IP* (input-only)							-
TDI	TDI	TDI	TDI	TDI	TDI	TDI	V _{CCAUX}
TMS	TMS	TMS	TMS	TMS	TMS	TMS	V _{CCAUX}
ТСК	TCK	ТСК	TCK	TCK	ТСК	ТСК	V _{CCAUX}
TDO	TDO	TDO	TDO	TDO	TDO	TDO	V _{CCAUX}
PROG_B	PROG_B	PROG_B	PROG_B	PROG_B	PROG_B	PROG_B	V _{CCAUX}
DONE	DONE	DONE	DONE	DONE	DONE	DONE	V _{CCAUX}
HSWAP	HSWAP	HSWAP	HSWAP	HSWAP	HSWAP	HSWAP	0
M2	0	0	0	1	1	1	2
M1	0	0	1	0	1	1	2
МО	0	1	0 = Up 1 = Down	1	0	1	2
CCLK	CCLK (I/O)	CCLK (I/O)	CCLK (I/O)		CCLK (I)	CCLK (I)	2
INIT_B	INIT_B	INIT_B	INIT_B		INIT_B	INIT_B	2
CSO_B		CSO_B	CSO_B		CSO_B		2
DOUT/BUSY	DOUT	DOUT	BUSY		BUSY	DOUT	2
MOSI/CSI_B		MOSI	CSI_B		CSI_B		2
D7			D7		D7		2
D6			D6		D6		2
D5			D5		D5		2
D4			D4		D4		2
D3			D3		D3		2
D2			D2		D2		2
D1			D1		D1		2

iMPACT Dummy VS2 **SPI Read Command** VS1 VS0 **SPI Serial Flash Vendor SPI Flash Family** Programming Bytes Support M25Pxx Yes STMicroelectronics (ST) M25PExx/M45PExx AT45DB 'D'-Series Data Yes Flash Atmel AT26 / AT25(1) Intel **S**33 Spansion (AMD, Fujitsu) S25FLxxxA FAST READ (0x0B) Winbond (NexFlash) NX25 / W25 1 1 1 1 (see Figure 53) Macronix MX25Lxxxx SST25LFxxxA Silicon Storage Technology (SST) SST25VFxxxA Programmable Microelectronics Corp. Pm25LVxxx (PMC) AMIC Technology A25L Eon Silicon Solution, Inc. **EN25** M25Pxx STMicroelectronics (ST) Yes M25PExx/M45PExx Spansion (AMD, Fujitsu) S25FLxxxA Winbond (NexFlash) NX25 / W25 Macronix MX25Lxxxx READ (0x03) 1 0 1 0 (see Figure 53) SST25LFxxxA Silicon Storage Technology SST25VFxxxA (SST) SST25VFxxx Programmable Microelectronics Corp. Pm25LVxxx (PMC) AT45DB DataFlash READ ARRAY (0xE8) (use only 'C' or 'D' 1 1 0 4 **Atmel Corporation** Yes (see Figure 54) Series for Industrial temperature range) Others Reserved

Table 53: Variant Select Codes for Various SPI Serial Flash PROMs

Notes:

1. See iMPACT documentation for specific device support.

WRITER NOTE: Many of the URLs in this table are obsolete or otherwise broken.

Daisy-Chaining

If the application requires multiple FPGAs with different configurations, then configure the FPGAs using a daisy chain, as shown in Figure 57. Daisy-chaining from a single SPI serial Flash PROM is supported in Stepping 1 devices. It is not supported in Stepping 0 devices. Use SPI Flash mode (M[2:0] = <0:0:1>) for the FPGA connected to the Platform Flash PROM and Slave Serial mode (M[2:0] = <1:1:1>) for all other FPGAs in the daisy-chain. After the master FPGA—the FPGA on the left in the diagram—finishes loading its configuration data from the SPI Flash PROM, the master device uses its DOUT output pin to supply data to the next device in the daisy-chain, on the falling CCLK edge.

Design Note

SPI mode daisy chains are supported only in Stepping 1 silicon versions.



Figure 57: Daisy-Chaining from SPI Flash Mode (Stepping 1)

Programming Support

For successful daisy-chaining, the *DONE_cycle* configuration option must be set to cycle 5 or sooner. The default cycle is 4. See Table 69 and the Start-Up section for additional information.

U In production applications, the SPI Flash PROM is usually pre-programmed before it is mounted on the printed circuit board. The <u>Xilinx ISE development software</u> produces industry-standard programming files that can be used with third-party gang programmers. Consult your specific SPI Flash vendor for recommended production programming solutions. In-system programming support is available from some third-party PROM programmers using a socket adapter with attached wires. To gain access to the SPI Flash signals, drive the FPGA's PROG_B input Low with an open-drain driver. This action places all FPGA I/O pins, including those attached to the SPI Flash, in high-impedance (Hi-Z). If the HSWAP input is Low, the I/Os have pull-up resistors to the V_{CCO} input on their respective I/O bank. The external programming hardware then has direct access to the SPI Flash pins. The programming access points are highlighted in the gray box in Figure 53, Figure 54, and Figure 57.

Beginning with the Xilinx ISE 8.2i software release, the iMPACT programming utility provides direct, in-system prototype programming support for STMicro M25P-series

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Readback

FPGA configuration data can be read back using either the Slave Parallel or JTAG mode. This function is disabled if the Bitstream Generator *Security* option is set to either *Level1* or *Level2*.

Along with the configuration data, it is possible to read back the contents of all registers and distributed RAM.

To synchronously control when register values are captured for readback, use the CAPTURE_SPARTAN3 library primitive, which applies for both Spartan-3 and Spartan-3E FPGA families.

The Readback feature is available in most Spartan-3E FPGA product options, as indicated in Table 68. The Readback feature is not available in the XC3S1200E and XC3S1600E FPGAs when using the -4 speed grade in the Commercial temperature grade. Similarly, block RAM Readback support is not available in the -4 speed grade, Commercial temperature devices. If Readback is required in an XC3S1200E or XC3S1600E FPGA, or if block RAM Readback is required on any Spartan-3E FPGA, upgrade to either the Industrial temperature grade version or the -5 speed grade.

The Xilinx iMPACT programming software uses the Readback feature for its optional Verify and Readback operations. The Xilinx ChipScope™ software presently does not use Readback but may in future updates.

Table 68: Readback Support in Spartan-3E FPGAs

Temperature Range	Comm	Industrial							
Speed Grade	-4	-5	-4						
Block RAM Readback									
All Spartan-3E FPGAs	No	Yes	Yes						
General Readback (regi	sters, distrik	outed RAM)							
XC3S100E	Yes	Yes	Yes						
XC3S250E	Yes	Yes	Yes						
XC3S500E	Yes	Yes	Yes						
XC3S1200E	No	Yes	Yes						
XC3S1600E	No	Yes	Yes						

Timing Measurement Methodology

When measuring timing parameters at the programmable I/Os, different signal standards call for different test conditions. Table 95 lists the conditions to use for each standard.

The method for measuring Input timing is as follows: A signal that swings between a Low logic level of V_L and a High logic level of V_H is applied to the Input under test. Some standards also require the application of a bias voltage to the V_{REF} pins of a given bank to properly set the input-switching threshold. The measurement point of the Input signal (V_M) is commonly located halfway between V_L and V_H.

The Output test setup is shown in Figure 72. A termination voltage V_T is applied to the termination resistor R_T, the other end of which is connected to the Output. For each standard, R_T and V_T generally take on the standard values recommended for minimizing signal reflections. If the standard does not ordinarily use terminations (e.g.,

LVCMOS, LVTTL), then R_T is set to $1M\Omega$ to indicate an open connection, and V_T is set to zero. The same measurement point (V_M) that was used at the Input is also used at the Output.



Notes:

1. The names shown in parentheses are used in the IBIS file.

Figure 72: Output Test Setup

Signal Standard			Inputs		Out	puts	Inputs and Outputs
(1051A	NDARD)	V _{REF} (V)	V _L (V)	V _H (V)	R_T (Ω)	V _T (V)	V _M (V)
Single-Ende	d						
LVTTL		-	0	3.3	1M	0	1.4
LVCMOS33		-	0	3.3	1M	0	1.65
LVCMOS25		-	0	2.5	1M	0	1.25
LVCMOS18		-	0	1.8	1M	0	0.9
LVCMOS15		-	0	1.5	1M	0	0.75
LVCMOS12		-	0	1.2	1M	0	0.6
PCI33_3	Rising	-	Note 3	Note 3	25	0	0.94
	Falling				25	3.3	2.03
PCI66_3	Rising	-	Note 3	Note 3	25	0	0.94
	Falling				25	3.3	2.03
HSTL_I_18		0.9	V _{REF} – 0.5	V _{REF} + 0.5	50	0.9	V _{REF}
HSTL_III_18		1.1	V _{REF} – 0.5	V _{REF} + 0.5	50	1.8	V _{REF}
SSTL18_I		0.9	V _{REF} – 0.5	V _{REF} + 0.5	50	0.9	V _{REF}
SSTL2_I		1.25	V _{REF} – 0.75	V _{REF} + 0.75	50	1.25	V _{REF}
Differential		•		•		•	
LVDS_25		-	V _{ICM} – 0.125	V _{ICM} + 0.125	50	1.2	V _{ICM}
BLVDS_25		-	V _{ICM} – 0.125	V _{ICM} + 0.125	1M	0	V _{ICM}
MINI_LVDS_2	25	-	V _{ICM} – 0.125	V _{ICM} + 0.125	50	1.2	V _{ICM}
LVPECL_25		-	V _{ICM} - 0.3	V _{ICM} + 0.3	1M	0	V _{ICM}
RSDS_25		-	V _{ICM} - 0.1	V _{ICM} + 0.1	50	1.2	V _{ICM}

Table 95: Test Methods for Timing Measurement at I/Os

Simultaneously Switching Output Guidelines

This section provides guidelines for the recommended maximum allowable number of Simultaneous Switching Outputs (SSOs). These guidelines describe the maximum number of user I/O pins of a given output signal standard that should simultaneously switch in the same direction, while maintaining a safe level of switching noise. Meeting these guidelines for the stated test conditions ensures that the FPGA operates free from the adverse effects of ground and power bounce.

Ground or power bounce occurs when a large number of outputs simultaneously switch in the same direction. The output drive transistors all conduct current to a common voltage rail. Low-to-High transitions conduct to the V_{CCO} rail; High-to-Low transitions conduct to the GND rail. The resulting cumulative current transient induces a voltage difference across the inductance that exists between the die pad and the power supply or ground return. The inductance is associated with bonding wires, the package lead frame, and any other signal routing inside the package. Other variables contribute to SSO noise levels, including stray inductance on the PCB as well as capacitive loading at receivers. Any SSO-induced voltage consequently affects internal switching noise margins and ultimately signal quality.

Table 96 and Table 97 provide the essential SSO guidelines. For each device/package combination, Table 96 provides the number of equivalent V_{CCO} /GND pairs. The

equivalent number of pairs is based on characterization and might not match the physical number of pairs. For each output signal standard and drive strength, Table 97 recommends the maximum number of SSOs, switching in the same direction, allowed per V_{CCO} /GND pair within an I/O bank. The guidelines in Table 97 are categorized by package style. Multiply the appropriate numbers from Table 96 and Table 97 to calculate the maximum number of SSOs allowed within an I/O bank. Exceeding these SSO guidelines might result in increased power or ground bounce, degraded signal integrity, or increased system jitter.

SSO_{MAX}/IO Bank = Table 96 x Table 97

The recommended maximum SSO values assumes that the FPGA is soldered on the printed circuit board and that the board uses sound design practices. The SSO values do not apply for FPGAs mounted in sockets, due to the lead inductance introduced by the socket.

The number of SSOs allowed for quad-flat packages (VQ, TQ, PQ) is lower than for ball grid array packages (FG) due to the larger lead inductance of the quad-flat packages. The results for chip-scale packaging (CP132) are better than quad-flat packaging but not as high as for ball grid array packaging. Ball grid array packages are recommended for applications with a large number of simultaneously switching outputs.

Dovico		Package Style (including Pb-free)											
Device	VQ100	CP132	TQ144	PQ208	FT256	FG320	FG400	FG484					
XC3S100E	2	2	2	-	-	-	-	-					
XC3S250E	2	2	2	3	4	-	-	-					
XC3S500E	2	2	-	3	4	5	-	-					
XC3S1200E	-	-	-	-	4	5	6	-					
XC3S1600E	-	-	-	-	-	5	6	7					

 Table 96: Equivalent V_{CCO}/GND Pairs per Bank

Table 107: Switching Characteristics for the DFS

			Speed Grade					
Symbol	Symbol Description			-	·5	-4		Units
				Min	Max	Min	Max	
Output Frequency Ranges	s							
CLKOUT_FREQ_FX_LF	Frequency for the CLKFX and CLKFX180 outputs, low frequencies	Stepping 0	XC3S100E XC3S250E XC3S500E	N/A	N/A	5	90	MHz
CLKOUT_FREQ_FX_HF	Frequency for the CLKFX and CLKFX180 outputs, high frequencies	T	XC3S1600E			220	307	MHz
CLKOUT_FREQ_FX	Frequency for the CLKFX and	Stepping 0	XC3S1200E			5	307	MHz
	CLKFX180 outputs	Stepping 1	All	5	333		311	MHz
Output Clock Jitter ^(2,3)								
CLKOUT_PER_JITT_FX	Period jitter at the CLKFX and		All	Тур	Max	Тур	Max	
	CLKFX180 outputs.	CLKIN ≤ 20 MHz			Note 6		ps	
		CLKIN > 20 MHz		±[1% of CLKFX period	±[1% of CLKFX period	±[1% of CLKFX period	±[1% of CLKFX period	ps
Duty Cyclo ^(4,5)				+ 100]	+ 200]	+ 100]	+ 200j	
	Duty avala provision for the CLK	V and CLKEV190	A II		110/ of		110/ of	
CEROUT_DUTT_CTCLE_FX	outputs, including the BUFGMUX duty-cycle distortion	Duty cycle precision for the CLKFX and CLKFX180 outputs, including the BUFGMUX and clock tree duty-cycle distortion			CLKFX period + 400]	-	CLKFX period + 400]	ps
Phase Alignment ⁽⁵⁾							-	
CLKOUT_PHASE_FX	Phase offset between the DFS CL DLL CLK0 output when both the used	KFX output and the DFS and DLL are	All	-	±200	-	±200	ps
CLKOUT_PHASE_FX180	Phase offset between the DFS CL the DLL CLK0 output when both th used	All	-	±[1% of CLKFX period + 300]	-	±[1% of CLKFX period + 300]	ps	
Lock Time							-	
LOCK_FX ⁽²⁾	The time from deassertion at the DCM's Reset input to the rising	$\begin{array}{l} 5 \text{ MHz} \leq \text{F}_{\text{CLKIN}} \\ \leq 15 \text{ MHz} \end{array}$	All	-	5	-	5	ms
transition at its LOCKED output. The DFS asserts LOCKED when the CLKFX and CLKFX180 signals are valid. If using both the DLL and the DFS, use the longer locking time.		F _{CLKIN} > 15 MHz		-	450	-	450	μs

Notes:

- 1. The numbers in this table are based on the operating conditions set forth in Table 77 and Table 106.
- 2. For optimal jitter tolerance and faster lock time, use the CLKIN_PERIOD attribute.
- Maximum output jitter is characterized within a reasonable noise environment (150 ps input period jitter, 40 SSOs and 25% CLB switching). Output jitter strongly depends on the environment, including the number of SSOs, the output drive strength, CLB utilization, CLB switching activities, switching frequency, power supply and PCB design. The actual maximum output jitter depends on the system application.
- 4. The CLKFX and CLKFX180 outputs always have an approximate 50% duty cycle.
- Some duty-cycle and alignment specifications include 1% of the CLKFX output period or 0.01 UI.
 Example: The data sheet specifies a maximum jitter of ±[1% of CLKFX period + 300]. Assume the CLKFX output frequency is 100 MHz. The equivalent CLKFX period is 10 ns and 1% of 10 ns is 0.1 ns or 100 ps. According to the data sheet, the maximum jitter is ±[100 ps + 300 ps] = ±400 ps.
- 6. Use the Spartan-3A Jitter Calculator (<u>www.xilinx.com/support/documentation/data_sheets/s3a_jitter_calc.zip</u>) to estimate DFS output jitter. Use the Clocking Wizard to determine jitter for a specific design.

TQ144: 144-lead Thin Quad Flat Package

The XC3S100E and the XC3S250E FPGAs are available in the 144-lead thin quad flat package, TQ144. Both devices share a common footprint for this package as shown in Table 137 and Figure 82.

Table 137 lists all the package pins. They are sorted by bank number and then by pin name of the largest device. Pins that form a differential I/O pair appear together in the table. The table also shows the pin number for each pin and the pin type, as defined earlier. The TQ144 package only supports 20 address output pins in the Byte-wide Peripheral Interface (BPI) configuration mode. In larger packages, there are 24 BPI address outputs.

An electronic version of this package pinout table and footprint diagram is available for download from the Xilinx web site at:

http://www.xilinx.com/support/documentation/data_sheets /s3e_pin.zip

Pinout Table

Table 137: TQ144 Package Pinout

Bank	XC3S100E Pin Name	XC3S250E Pin Name	TQ144 Pin	Туре
0	10	IO	P132	I/O
0	IO/VREF_0	IO/VREF_0	P124	VREF
0	IO_L01N_0	IO_L01N_0	P113	I/O
0	IO_L01P_0	IO_L01P_0	P112	I/O
0	IO_L02N_0	IO_L02N_0	P117	I/O
0	IO_L02P_0	IO_L02P_0	P116	I/O
0	IO_L04N_0/GCLK5	IO_L04N_0/GCLK5	P123	GCLK
0	IO_L04P_0/GCLK4	IO_L04P_0/GCLK4	P122	GCLK
0	IO_L05N_0/GCLK7	IO_L05N_0/GCLK7	P126	GCLK
0	IO_L05P_0/GCLK6	IO_L05P_0/GCLK6	P125	GCLK
0	IO_L07N_0/GCLK11	IO_L07N_0/GCLK11	P131	GCLK
0	IO_L07P_0/GCLK10	IO_L07P_0/GCLK10	P130	GCLK
0	IO_L08N_0/VREF_0	IO_L08N_0/VREF_0	P135	VREF
0	IO_L08P_0	IO_L08P_0	P134	I/O
0	IO_L09N_0	IO_L09N_0	P140	I/O
0	IO_L09P_0	IO_L09P_0	P139	I/O
0	IO_L10N_0/HSWAP	IO_L10N_0/HSWAP	P143	DUAL
0	IO_L10P_0	IO_L10P_0	P142	I/O
0	IP	IP	P111	INPUT
0	IP	IP	P114	INPUT
0	IP	IP	P136	INPUT
0	IP	IP	P141	INPUT
0	IP_L03N_0	IP_L03N_0	P120	INPUT
0	IP_L03P_0	IP_L03P_0	P119	INPUT
0	IP_L06N_0/GCLK9	IP_L06N_0/GCLK9	P129	GCLK
0	IP_L06P_0/GCLK8	IP_L06P_0/GCLK8	P128	GCLK
0	VCCO_0	VCCO_0	P121	VCCO
0	VCCO_0	VCCO_0	P138	VCCO
1	IO/A0	IO/A0	P98	DUAL
1	IO/VREF_1	IO/VREF_1	P83	VREF
1	IO_L01N_1/A15	IO_L01N_1/A15	P75	DUAL
1	IO_L01P_1/A16	IO_L01P_1/A16	P74	DUAL
1	IO_L02N_1/A13	IO_L02N_1/A13	P77	DUAL

Table 137: TQ144 Package Pinout (Cont'd)

Bank	XC3S100E Pin Name	XC3S250E Pin Name	TQ144 Pin	Туре
2	IP	IP	P38	INPUT
2	IP	IP	P41	INPUT
2	IP	IP	P69	INPUT
2	IP_L03N_2/VREF_2	IP_L03N_2/VREF_2	P48	VREF
2	IP_L03P_2	IP_L03P_2	P47	INPUT
2	IP_L06N_2/M2/GCLK1	IP_L06N_2/M2/GCLK1	P57	DUAL/GCLK
2	IP_L06P_2/RDWR_B/GCLK0	IP_L06P_2/RDWR_B/GCLK0	P56	DUAL/GCLK
2	VCCO_2	VCCO_2	P42	VCCO
2	VCCO_2	VCCO_2	P49	VCCO
2	VCCO_2	VCCO_2	P64	VCCO
3	IP/VREF_3	IO/VREF_3	P31	100E: VREF(INPUT)
3			P3	
3			P2	1/0
3			P5	VBEE
3			P4	1/0
3			P8	1/0
3			P7	1/0
3			P15	I HCLK
3			P1/	LHCLK
3			P17	LHCLK
3			P16	LHCLK
3			P21	LHCLK
3			P20	LHCLK
3			P23	LHCLK
3			P22	LHCLK
3			P26	1/0
3			P25	1/0
3			P33	1/0
3			P32	1/0
3			P35	1/0
3			P34	1/0
3	IP		P6	INPUT
3	10	IP	P10	100E: 1/0
, , , , , , , , , , , , , , , , , , ,				250E: INPUT
3	IP	IP	P18	INPUT
3	IP	IP	P24	INPUT
3	10	IP	P29	100E: I/O
				<i>250E:</i> INPUT
3	IP	IP	P36	INPUT
3	IP/VREF_3	IP/VREF_3	P12	VREF
3	VCCO_3	VCCO_3	P13	VCCO
3	VCCO_3	VCCO_3	P28	VCCO
GND	GND	GND	P11	GND
GND	GND	GND	P19	GND
			-	

Table 141: PQ208 Package Pinout (Cont'd)

Bank	XC3S250E XC3S500E Pin Name	PQ208 Pin	Туре
1	IO_L15N_1/LDC0	P151	DUAL
1	IO_L15P_1/HDC	P150	DUAL
1	IO_L16N_1/LDC2	P153	DUAL
1	IO_L16P_1/LDC1	P152	DUAL
1	IP	P110	INPUT
1	IP	P118	INPUT
1	IP	P124	INPUT
1	IP	P130	INPUT
1	IP	P142	INPUT
1	IP	P148	INPUT
1	IP	P154	INPUT
1	IP/VREF_1	P136	VREF
1	VCCO_1	P114	VCCO
1	VCCO_1	P125	VCCO
1	VCCO_1	P143	VCCO
2	IO/D5	P76	DUAL
2	IO/M1	P84	DUAL
2	IO/VREF_2	P98	VREF
2	IO_L01N_2/INIT_B	P56	DUAL
2	IO_L01P_2/CSO_B	P55	DUAL
2	IO_L03N_2/MOSI/CSI_B	P61	DUAL
2	IO_L03P_2/DOUT/BUSY	P60	DUAL
2	IO_L04N_2	P63	I/O
2	IO_L04P_2	P62	I/O
2	IO_L05N_2	P65	I/O
2	IO_L05P_2	P64	I/O
2	IO_L06N_2	P69	I/O
2	IO_L06P_2	P68	I/O
2	IO_L08N_2/D6/GCLK13	P75	DUAL/GCLK
2	IO_L08P_2/D7/GCLK12	P74	DUAL/GCLK
2	IO_L09N_2/D3/GCLK15	P78	DUAL/GCLK
2	IO_L09P_2/D4/GCLK14	P77	DUAL/GCLK
2	IO_L11N_2/D1/GCLK3	P83	DUAL/GCLK
2	IO_L11P_2/D2/GCLK2	P82	DUAL/GCLK
2	IO_L12N_2/DIN/D0	P87	DUAL
2	IO_L12P_2/M0	P86	DUAL
2	IO_L13N_2	P90	I/O
2	IO_L13P_2	P89	I/O
2	IO_L14N_2/A22	P94	DUAL
2	IO_L14P_2/A23	P93	DUAL
2	IO_L15N_2/A20	P97	DUAL
2	IO_L15P_2/A21	P96	DUAL
2	IO_L16N_2/VS1/A18	P100	DUAL

Table 141: PQ208 Package Pinout (Cont'd)

Bank	XC3S250E XC3S500E Pin Name	PQ208 Pin	Туре
2		P99	DUAI
2		P103	DUAL
2	IO_L17P_2/VS0/A17	P102	
2	IP	P54	INPLIT
2	IP	P91	
2	IP	P101	
2		P58	
2	IP 1 02P 2	P57	
2	IP 107N 2//BEE 2	P72	VBEE
2	IP 107P 2	P71	INPLIT
2	IP_L10N_2/M2/GCLK1	P81	
2	IP L10P 2/RDWR B/	P80	DUAL/GCLK
	GCLK0		
2	VCCO_2	P59	VCCO
2	VCCO_2	P73	VCCO
2	VCCO_2	P88	VCCO
3	IO/VREF_3	P45	VREF
3	IO_L01N_3	P3	I/O
3	IO_L01P_3	P2	I/O
3	IO_L02N_3/VREF_3	P5	VREF
3	IO_L02P_3	P4	I/O
3	IO_L03N_3	P9	I/O
3	IO_L03P_3	P8	I/O
3	IO_L04N_3	P12	I/O
3	IO_L04P_3	P11	I/O
3	IO_L05N_3	P16	I/O
3	IO_L05P_3	P15	I/O
3	IO_L06N_3	P19	I/O
3	IO_L06P_3	P18	I/O
3	IO_L07N_3/LHCLK1	P23	LHCLK
3	IO_L07P_3/LHCLK0	P22	LHCLK
3	IO_L08N_3/LHCLK3	P25	LHCLK
3	IO_L08P_3/LHCLK2	P24	LHCLK
3	IO_L09N_3/LHCLK5	P29	LHCLK
3	IO_L09P_3/LHCLK4	P28	LHCLK
3	IO_L10N_3/LHCLK7	P31	LHCLK
3	IO_L10P_3/LHCLK6	P30	LHCLK
3	IO_L11N_3	P34	I/O
3	IO_L11P_3	P33	I/O
3	IO_L12N_3	P36	I/O
3	IO_L12P_3	P35	I/O
3	IO_L13N_3	P40	I/O
3	IO_L13P_3	P39	I/O
3	IO_L14N_3	P42	I/O

Table 143: FT256 Package Pinout (Cont'd)

Bank	XC3S250E Pin Name	XC3S500E Pin Name	XC3S1200E Pin Name	FT256 Ball	Туре
2	N.C. (♠)	IO_L14N_2/VREF_2	IO_L14N_2/VREF_2	R10	<i>250E:</i> N.C. <i>500E:</i> VREF
					1200E: VREF
2	N.C. (♠)	IO_L14P_2	IO_L14P_2	P10	250E: N.C. 500E: I/O 1200E: I/O
2	IO_L15N_2	IO_L15N_2	IO_L15N_2	M10	I/O
2	IO_L15P_2	IO_L15P_2	IO_L15P_2	N10	I/O
2	IO_L16N_2/A22	IO_L16N_2/A22	IO_L16N_2/A22	P11	DUAL
2	IO_L16P_2/A23	IO_L16P_2/A23	IO_L16P_2/A23	R11	DUAL
2	IO_L18N_2/A20	IO_L18N_2/A20	IO_L18N_2/A20	N12	DUAL
2	IO_L18P_2/A21	IO_L18P_2/A21	IO_L18P_2/A21	P12	DUAL
2	IO_L19N_2/VS1/A18	IO_L19N_2/VS1/A18	IO_L19N_2/VS1/A18	R13	DUAL
2	IO_L19P_2/VS2/A19	IO_L19P_2/VS2/A19	IO_L19P_2/VS2/A19	T13	DUAL
2	IO_L20N_2/CCLK	IO_L20N_2/CCLK	IO_L20N_2/CCLK	R14	DUAL
2	IO_L20P_2/VS0/A17	IO_L20P_2/VS0/A17	IO_L20P_2/VS0/A17	P14	DUAL
2	IP	IP	IP	T2	INPUT
2	IP	IP	IP	T14	INPUT
2	IP_L02N_2	IP_L02N_2	IP_L02N_2	R3	INPUT
2	IP_L02P_2	IP_L02P_2	IP_L02P_2	Т3	INPUT
2	IP_L08N_2/VREF_2	IP_L08N_2/VREF_2	IP_L08N_2/VREF_2	T7	VREF
2	IP_L08P_2	IP_L08P_2	IP_L08P_2	R7	INPUT
2	IP_L11N_2/M2/GCLK1	IP_L11N_2/M2/GCLK1	IP_L11N_2/M2/GCLK1	R9	DUAL/GCLK
2	IP_L11P_2/RDWR_B/ GCLK0	IP_L11P_2/RDWR_B/ GCLK0	IP_L11P_2/RDWR_B/ GCLK0	Т9	DUAL/GCLK
2	IP_L17N_2	IP_L17N_2	IP_L17N_2	M11	INPUT
2	IP_L17P_2	IP_L17P_2	IP_L17P_2	N11	INPUT
2	VCCO_2	VCCO_2	VCCO_2	L7	VCCO
2	VCCO_2	VCCO_2	VCCO_2	L10	VCCO
2	VCCO_2	VCCO_2	VCCO_2	R5	VCCO
2	VCCO_2	VCCO_2	VCCO_2	R12	VCCO
3	IO_L01N_3	IO_L01N_3	IO_L01N_3	B2	I/O
3	IO_L01P_3	IO_L01P_3	IO_L01P_3	B1	I/O
3	IO_L02N_3/VREF_3	IO_L02N_3/VREF_3	IO_L02N_3/VREF_3	C2	VREF
3	IO_L02P_3	IO_L02P_3	IO_L02P_3	C1	I/O
3	IO_L03N_3	IO_L03N_3	IO_L03N_3	E4	I/O
3	IO_L03P_3	IO_L03P_3	IO_L03P_3	E3	I/O
3	N.C. (♠)	IO_L04N_3/VREF_3	IO_L04N_3/VREF_3	F4	250E: N.C. 500E: VREF 1200E: VREF
3	N.C. (�)	IO_L04P_3	IO_L04P_3	F3	250E: N.C. 500E: I/O 1200E: I/O
3	IO_L05N_3	IO_L05N_3	IO_L05N_3	E1	I/O
3	IO_L05P_3	IO_L05P_3	IO_L05P_3	D1	I/O
3	IO_L06N_3	IO_L06N_3	IO_L06N_3	G4	I/O

Table 148: FG320 Package Pinout (Cont'd)

Bank	XC3S500E Pin Name	XC3S1200E Pin Name	XC3S1600E Pin Name	FG320 Ball	Туре
3	N.C. (♦)	IO_L22P_3	IO_L22P_3	P3	500E: N.C. 1200E: I/O 1600E: I/O
3	IO_L23N_3	IO_L23N_3	IO_L23N_3	R2	I/O
3	IO_L23P_3	IO_L23P_3	IO_L23P_3	R3	I/O
3	IO_L24N_3	IO_L24N_3	IO_L24N_3	T1	I/O
3	IO_L24P_3	IO_L24P_3	IO_L24P_3	T2	I/O
3	IP	IP	IP	D3	INPUT
3	10	IP	IP	F4	500E: I/O 1200E: INPUT 1600E: INPUT
3	IP	IP	IP	F5	INPUT
3	IP	IP	IP	G1	INPUT
3	IP	IP	IP	J7	INPUT
3	IP	IP	IP	K2	INPUT
3	IP	IP	IP	K7	INPUT
3	IP	IP	IP	M1	INPUT
3	IP	IP	IP	N1	INPUT
3	IP	IP	IP	N2	INPUT
3	IP	IP	IP	R1	INPUT
3	IP	IP	IP	U1	INPUT
3	IP/VREF_3	IP/VREF_3	IP/VREF_3	J6	VREF
3	IO/VREF_3	IP/VREF_3	IP/VREF_3	R4	500E: VREF(I/O) 1200E: VREF(INPUT) 1600E: VREF(INPUT)
3	VCCO_3	VCCO_3	VCCO_3	F3	VCCO
3	VCCO_3	VCCO_3	VCCO_3	H7	VCCO
3	VCCO_3	VCCO_3	VCCO_3	K1	VCCO
3	VCCO_3	VCCO_3	VCCO_3	L7	VCCO
3	VCCO_3	VCCO_3	VCCO_3	N3	VCCO
GND	GND	GND	GND	A1	GND
GND	GND	GND	GND	A18	GND
GND	GND	GND	GND	B2	GND
GND	GND	GND	GND	B17	GND
GND	GND	GND	GND	C10	GND
GND	GND	GND	GND	G7	GND
GND	GND	GND	GND	G12	GND
GND	GND	GND	GND	H8	GND
GND	GND	GND	GND	H9	GND
GND	GND	GND	GND	H10	GND
GND	GND	GND	GND	H11	GND
GND	GND	GND	GND	J3	GND
GND	GND	GND	GND	J8	GND
GND	GND	GND	GND	J11	GND

Table 152: FG400 Package Pinout (Cont'd)

Bank	XC3S1200E XC3S1600E Pin Name	FG400 Ball	Туре
1	IP	L18	INPUT
1	IP	M20	INPUT
1	IP	N14	INPUT
1	IP	N20	INPUT
1	IP	P15	INPUT
1	IP	R16	INPUT
1	IP	R19	INPUT
1	IP/VREF_1	E19	VREF
1	IP/VREF_1	K18	VREF
1	VCCO_1	D19	VCCO
1	VCCO_1	G17	VCCO
1	VCCO_1	K15	VCCO
1	VCCO_1	K19	VCCO
1	VCCO_1	N17	VCCO
1	VCCO_1	T19	VCCO
2	10	P8	I/O
2	10	P13	I/O
2	10	R9	I/O
2	10	R13	I/O
2	10	W15	I/O
2	10	Y5	I/O
2	10	Y7	I/O
2	10	Y13	I/O
2	IO/D5	N11	DUAL
2	IO/M1	T11	DUAL
2	IO/VREF_2	Y3	VREF
2	IO/VREF_2	Y17	VREF
2	IO_L01N_2/INIT_B	V4	DUAL
2	IO_L01P_2/CSO_B	U4	DUAL
2	IO_L03N_2/MOSI/CSI_B	V5	DUAL
2	IO_L03P_2/DOUT/BUSY	U5	DUAL
2	IO_L04N_2	Y4	I/O
2	IO_L04P_2	W4	I/O
2	IO_L06N_2	T6	I/O
2	IO_L06P_2	T5	I/O
2	IO_L07N_2	U7	I/O
2	IO_L07P_2	V7	I/O
2	IO_L09N_2/VREF_2	R7	VREF
2	IO_L09P_2	T7	I/O
2	IO_L10N_2	V8	I/O
2	IO_L10P_2	W8	I/O
2	IO_L12N_2	U9	I/O
2	IO_L12P_2	V9	I/O

Table 152: FG400 Package Pinout (Cont'd)

Bank	XC3S1200E XC3S1600E Pin Name	FG400 Ball	Туре
2	IO_L13N_2	Y8	I/O
2	IO_L13P_2	Y9	I/O
2	IO_L15N_2/D6/GCLK13	W10	DUAL/ GCLK
2	IO_L15P_2/D7/GCLK12	W9	DUAL/ GCLK
2	IO_L16N_2/D3/GCLK15	P10	DUAL/ GCLK
2	IO_L16P_2/D4/GCLK14	R10	DUAL/ GCLK
2	IO_L18N_2/D1/GCLK3	V11	DUAL/ GCLK
2	IO_L18P_2/D2/GCLK2	V10	DUAL/ GCLK
2	IO_L19N_2/DIN/D0	Y12	DUAL
2	IO_L19P_2/M0	Y11	DUAL
2	IO_L21N_2	U12	I/O
2	IO_L21P_2	V12	I/O
2	IO_L22N_2/VREF_2	W12	VREF
2	IO_L22P_2	W13	I/O
2	IO_L24N_2	U13	I/O
2	IO_L24P_2	V13	I/O
2	IO_L25N_2	P14	I/O
2	IO_L25P_2	R14	I/O
2	IO_L27N_2/A22	Y14	DUAL
2	IO_L27P_2/A23	Y15	DUAL
2	IO_L28N_2	T15	I/O
2	IO_L28P_2	U15	I/O
2	IO_L30N_2/A20	V16	DUAL
2	IO_L30P_2/A21	U16	DUAL
2	IO_L31N_2/VS1/A18	Y18	DUAL
2	IO_L31P_2/VS2/A19	W18	DUAL
2	IO_L32N_2/CCLK	W19	DUAL
2	IO_L32P_2/VS0/A17	Y19	DUAL
2	IP	T16	INPUT
2	IP	W3	INPUT
2	IP_L02N_2	Y2	INPUT
2	IP_L02P_2	W2	INPUT
2	IP_L05N_2	V6	INPUT
2	IP_L05P_2	U6	INPUT
2	IP_L08N_2	Y6	INPUT
2	IP_L08P_2	W6	INPUT
2	IP_L11N_2	R8	INPUT
2	IP_L11P_2	Т8	INPUT
2	IP_L14N_2/VREF_2	T10	VREF

Revision History

The following table shows the revision history for this document.

Date	Version	Revision
03/01/05	1.0	Initial Xilinx release.
03/21/05	1.1	Added XC3S250E in the CP132 package to Table 129. Corrected number of differential I/O pairs on CP132. Added pinout and footprint information for the CP132, FG400, and FG484 packages. Removed IRDY and TRDY pins from the VQ100, TQ144, and PQ208 packages.
11/23/05	2.0	Corrected title of Table 153. Updated differential pair numbering for some pins in Bank 0 of the FG400 package, affecting Table 152 and Figure 87. Pin functionality and ball assignment were not affected. Added Package Thermal Characteristics section. Added package mass values to Table 125.
03/22/06	3.0	Included I/O pins, not just input-only pins under the VREF description in Table 124. Clarified that some global clock inputs are Input-only pins in Table 124. Added information on the XC3S100E in the CP132 package, affecting Table 129, Table 130, Table 133, Table 134, Table 136, and Figure 81. Ball A12 on the XC3S1600E in the FG320 package a full I/O pin, not an Input-only pin. Corrected the I/O counts for the XC3S1600E in the FG320 package, affecting Table 129, Table 150, Table 151, and Figure 86. Corrected pin type for XC3S1600E balls N14 and N15 in Table 148.
05/19/06	3.1	Minor text edits.
11/09/06	3.4	Added package thermal data for the XC3S100E in the CP132 package to Table 130. Corrected pin migration arrows for balls E17 and F4 between the XC3S500E and XC3S1600E in Table 151. Promoted Module 4 to Production status. Synchronized all modules to v3.4.
03/16/07	3.5	Minor formatting changes.
05/29/07	3.6	Corrected 'Lxx' to 'Lxxy' in Table 124. Noted that some GCLK and VREF pins are on INPUT pins in Table 124 and Table 129. Added link before Table 127 to Material Declaration Data Sheets.
04/18/08	3.7	Added XC3S500E VQG100 package. Added Material Declaration Data Sheet links in Table 127. Updated Thermal Characteristics in Table 130. Updated links.
08/26/09	3.8	Minor typographical updates.
10/29/12	4.0	Added Notice of Disclaimer. This product is not recommended for new designs. Updated the XC3S250E-FT256 in Table 129.

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